

<b>Notice of References Cited</b>	Application/Control No. 10/034,210	Applicant(s)/Patent Under Reexamination BANNON ET AL.	
	Examiner George D. Spisich	Art Unit 3616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,167,777	01-2001	Snell, William M.	74/493
	B	US-4,796,481	01-1989	Nolte, Frank	74/493
	C	US-4,900,059	02-1990	Kinoshita et al.	280/775
	D	US-5,035,446	07-1991	Arvidsson, Hans-Olof	280/775
	E	US-5,172,576	12-1992	Milton, Thomas J.	70/185
	F	US-5,178,411	01-1993	Fevre et al.	280/775
	G	US-5,409,261	04-1995	Yamaguchi, Mikio	280/775
	H	US-5,439,252	08-1995	Oxley et al.	280/775
	I	US-5,848,557	12-1998	Sugiki et al.	74/493
	J	US-2003/0172766	09-2003	Masucci, Paul M.	74/493
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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